Notice of References Cited Application/Control No. 10/709,470 Examiner Adolf Berhane Applicant(s)/Patent Under Reexamination LIN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,201,381	03-2001	Yasuda, Yukio	323/315
	В	US-6,563,295	05-2003	Juang, Dar-Chang	323/315
	С	US-6,737,849	05-2004	Eshraghi et al.	323/315
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		·			
	Р					
	α					
	R					
	S					·
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	>	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.